

Notice of References Cited

Application/Control No.

10/578,769

Applicant(s)/Patent Under
Reexamination
TAKEI ET AL.

Examiner

DIEU HIEN T. DUONG

Art Unit

2821

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,894,647	05-2005	Jenwatanavet, Jay	343/700MS
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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